

**Search Notes**

Application/Control No.

10/633,595

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

OIKAWA ET AL.

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
Updated	search in class 250, 340, 355	6/13/2005	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Files	N/A	6/15/2005	PL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (see attached)	6/13/2005	PL